

PTO/SS/08a (07-09)

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use as many sheets as necessary)			Application Number	10/588,232-Conf. #5423	
			Filing Date	August 3, 2006	
			First Named Inventor	Masayuki MORITA	
			Art Unit	1796	
			Examiner Name	S. Fang	
Sheet	1	of	2	Attorney Docket Number	0171-1294PUS1

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
	AA	US-2003/0215701-A1	11-20-2003	Nagasaki et al.	
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Examiner Initials*	Cite No.	Foreign Patent Document		Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages Or Relevant Figures Appear
		Country Code ² -Number ³ -Kind Code ⁴ (if known)	MM-DD-YYYY			
	BA	SU-592823		02-15-1978		
	BB	WO-2004/111108-A1		12-23-2004		
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Examiner Signature	/Shane Fang/	Date Considered	01/14/2010
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PTO/SB/08b (07-09)

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Sheet	2	of	2	Attorney Docket Number	0171-1294PUS1
NON PATENT LITERATURE DOCUMENTS					
Examiner Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.			T ^o
CA	United States Office Action dated August 27, 2009 in corresponding U.S. Application 10/585,757				
CB	United States Office Action dated June 9, 2009 in corresponding U.S. Application 10/585,757				
CC	VOLF et al., Solid State Ionics, Vol. 154-155, 2002, pgs. 57-63				
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CN	Denki Kagaku, Electrochemistry and Industrial Physicochemistry, 1986, vol. 54, no. 4, pp. 306-311.				
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CP	Journal of the American Chemical Society, the United States of America, 1995, vol. 117, no. 25, pp. 6791-6792.				
CQ	Chen et al., Acta Pharmaceutica Sinica, Vol. 27, No. 6, pp. 418-422, (1992)				
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CS	Thomas et al., Journal of Electroanalytical Chemistry, Vol. 501, No. 1-2, pp. 235-240, (2001).				
CT	International Preliminary Examination Report on Patentability (Form PCT/ISPEA/409)				
CU	International Search Report				
Examiner Signature	/Shane Fang/			Date Considered	01/14/2010

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